SCBS247G - AUGUST 1992 - REVISED JULY 1998

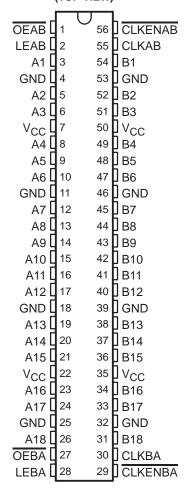
- **Members of the Texas Instruments** Widebus™ Family
- B-Port Outputs Have Equivalent 25- Ω Series Resistors, So No External Resistors Are Required
- State-of-the-Art *EPIC-IIB™* BiCMOS Design Significantly Reduces Power Dissipation
- **UBT** ™ (Universal Bus Transceiver) **Combines D-Type Latches and D-Type** Flip-Flops for Operation in Transparent, Latched, Clocked, or Clock-Enabled Mode
- Latch-Up Performance Exceeds 500 mA Per **JESD 17**
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$
- **High-Impedance State During Power Up** and Power Down
- Flow-Through Architecture Optimizes PCB Layout
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package **Using 25-mil Center-to-Center Spacings**

description

These 18-bit universal bus transceivers combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. The clock can be controlled by the clock-enable (CLKENAB and CLKENBA) inputs.

SN54ABT162601...WD PACKAGE SN74ABT162601...DGG OR DL PACKAGE (TOP VIEW)



For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. Output-enable OEAB is active-low. When OEAB is low, the outputs are active. When OEAB is high, the outputs are in the high-impedance state. Data flow for B to A is similar to that of A to B but uses \overline{OEBA} , LEBA, CLKBA, and $\overline{CLKENBA}$.

The B-port outputs, which are designed to source or sink up to 12 mA, include equivalent $25-\Omega$ series resistors to reduce overshoot and undershoot.

When V_{CC} is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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SN54ABT162601, SN74ABT162601 18-BIT UNIVERSAL BUS TRANSCEIVERS **WITH 3-STATE OUTPUTS**

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description (continued)

The SN54ABT162601 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABT162601 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE[†]

	INPUTS											
CLKENAB	OEAB	LEAB	CLKAB	Α	В							
Х	Н	Х	Х	Х	Z							
Х	L	Н	X	L	L							
Х	L	Н	X	Н	Н							
Н	L	L	X	Χ	в ₀ ‡							
Н	L	L	X	Χ	В ₀ ‡ В ₀ ‡							
L	L	L	\uparrow	L	L							
L	L	L	\uparrow	Н	Н							
L	L	L	L	Χ	в ₀ ‡							
L	L	L	Н	Χ	В ₀ ‡ В ₀ §							

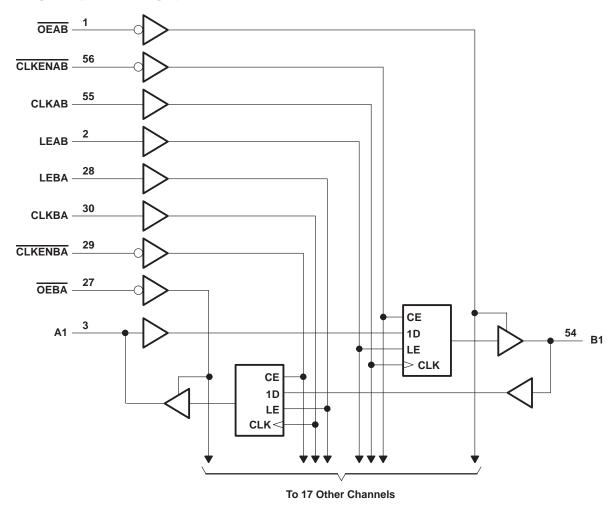
[†] A-to-B data flow is shown: B-to-A flow is similar but uses OEBA, LEBA, CLKBA, and CLKENBA.



[‡] Output level before the indicated steady-state input conditions were established

[§] Output level before the indicated steady-state input conditions were established, provided that CLKAB was low before LEAB went low

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (except I/O ports) (see Note 1)	
Voltage range applied to any output in the high or power-off state, VO	0.5 V to 5.5 V
Current into any output in the low state, IO: SN54ABT162601 (A port)	96 mA
SN74ABT162601 (A port)	128 mA
B port	30 mA
Input clamp current, I_{IK} ($V_I < 0$)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Package thermal impedance, θ _{JA} (see Note 2): DGG package	81°C/W
DL package	74°C/W
Storage temperature range, T _{stq}	. −65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.



SN54ABT162601, SN74ABT162601 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

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recommended operating conditions (see Note 3)

			SN54ABT	162601	SN74ABT	162601	UNIT	
						MAX		
VCC	Supply voltage	4.5	5.5	4.5	5.5	V		
V_{IH}	High-level input voltage		2		2		V	
V_{IL}	Low-level input voltage			0.8		0.8	V	
VI	Input voltage		0	Vcc	0	Vcc	V	
lou	High-level output current	A port		-24		-32	mA	
ЮН	High-level output current	B port		-12		-12	IIIA	
la.	Low lovel output outront	A port		48		64	mA	
lOL	Low-level output current	B port		12		12	IIIA	
Δt/Δν	Input transition rise or fall rate	Outputs enabled		10		10	ns/V	
Δt/ΔV _{CC}	Power-up ramp rate		200		200		μs/V	
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 3: All unused inputs of the devices must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application note, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CON	IDITIONS	Т	A = 25°C	;	SN54ABT	162601	SN74ABT162601		UNIT	
FAI	KAWETEK	TEST CON	IDITIONS	MIN	TYP [†]	MAX	MIN			MAX	UNIT	
٧ıK		$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA			-1.2		-1.2		-1.2	V	
		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.5			2.5		2.5			
	A	$V_{CC} = 5 V$,	$I_{OH} = -3 \text{ mA}$	3			3		3			
	A port	V 45V	I _{OH} = -24 mA	2			2					
V		V _{CC} = 4.5 V	I _{OH} = -32 mA	2*					2		V	
VOH		$V_{CC} = 4.5 \text{ V},$	I _{OH} = -1 mA	3.35			3.3		3.35		V	
	D nort	$V_{CC} = 5 V$,	$I_{OH} = -1 \text{ mA}$	3.85			3.8		3.85			
	B port	V 45V	$I_{OH} = -3 \text{ mA}$	3.1			3		3.1			
		V _{CC} = 4.5 V	I _{OH} = -12 mA	2.6					2.6			
	A port	V00 - 4 5 V	I _{OL} = 48 mA			0.55		0.55				
VOL	A port	V _{CC} = 4.5 V	I _{OL} = 64 mA			0.55*				0.55	V	
	B port	V _{CC} = 4.5 V,	I _{OL} = 12 mA			0.8		0.8		0.8		
V _{hys}					100						mV	
	Control inputs	V _{CC} = 0 to 5.5 V, V _I	= V _{CC} or GND			±1		±1		±1	μΑ	
ΙΙ	A or B ports	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}$ $V_I = V_{CC} \text{ or GND}$	/,			±20		±20		±20		
IOZPL	J	$V_{CC} = 0 \text{ to } 2.1 \text{ V},$ $V_{O} = 0.5 \text{ V to } 2.7 \text{ V},$	OE = X			±50		±50**		±50 μΑ		
IOZPE)	$V_{CC} = 2.1 \text{ V to 0},$ $V_{O} = 0.5 \text{ V to 2.7 V},$	OE = X			±50		±50**		±50	μΑ	
loz _H ‡	:	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}$ $V_{O} = 2.7 \text{ V}, \overline{OE} \ge 2 \text{ V}$				10		10		10	μΑ	
I _{OZL} ‡		$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V}$ $V_{O} = 0.5 \text{ V}, \text{ OE } \ge 2 \text{ V}$	/, /			-10		-10		-10	μА	
l _{off}		$V_{CC} = 0$,	V _I or V _O ≤ 4.5 V			±100*				±100	μΑ	
ICEX		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50		50		50	μΑ	
	A port	V 55V		-50	-100	-180	-50	-180	-50	-180	Δ	
ΙΟ§	B port	V _{CC} = 5.5 V,	$V_0 = 2.5 \text{ V}$	-25	-55	-100	-25	-100	-25	-100	mA	
		V _{CC} = 5.5 V,	Outputs high			3		3		3		
Icc	A or B ports	$I_{O} = 0$,	Outputs low			36		36		36	mA	
		$V_I = V_{CC}$ or GND	Outputs disabled			3		3		3		
ΔICC¶		V _{CC} = 5.5 V, One in Other inputs at V _{CC}				50		50		50		
Ci	Control inputs	V _I = 2.5 V or 0.5 V			3						pF	
C _{io}	A or B ports	V _O = 2.5 V or 0.5 V			9						pF	
.5	<u>' '</u>											

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply.



^{**} On products compliant to MIL-PRF-38535, this parameter is not production tested.

 $[\]dagger$ All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] The parameters IOZH and IOZL include the input leakage current.

[§] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[¶] This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

SN54ABT162601, SN74ABT162601 18-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

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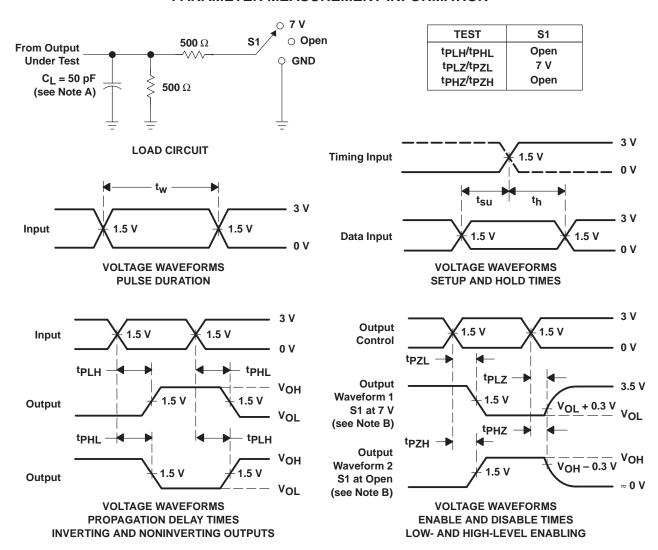
timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(see Figure 1)

				SN54ABT	162601	SN74ABT	162601	UNIT
				MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency			0	150	0	150	MHz
	Pulse duration	LEAB or LEBA high		2.5		2.5		
t _W	Puise duration	CLKAB or CLKBA high or low	3.3		3		ns	
		A before CLKAB↑ or B before CLKBA↑	4.8		4.3			
	Catum time	A. (1500 D. (1500 D.	CLK high	2.5		2.5		
t _{su}	Setup time	A before LEAB↓ or B before LEBA↓	CLK low	1.2		1		ns
		CLKEN before CLK↑	CLKEN before CLK↑					
		A after CLKAB↑ or B after CLKBA↑	0.5	0				
th	Hold time	A after LEAB↓ or B after LEBA↓	2		0.5		ns	
		CLKEN after CLK↑		0.5		0		

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V ₍	CC = 5 V A = 25°C	', ;	SN54ABT	162601	SN74ABT162601		UNIT
	(INFOT)	(0011-01)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f _{max}			150			150		150		MHz
^t PLH	A	В	1.5	2.8	4	1.5	5.1	1.5	4.8	ns
t _{PHL}	A	Ь	2	3.7	5.2	2	6.1	2	5.7	115
t _{PLH}	В	^	1	2.5	3.6	1	4.5	1	4	ns
t _{PHL}	Ь	А	2	3.3	4.5	2	5.1	2	4.9	115
^t PLH	LEBA	А	2	3.3	4.5	2	5.6	2	5	ns
t _{PHL}	LEDA	A .	2	3.6	4.7	2	5.4	2	5	115
^t PLH	LEAB	В	2	3.4	4.8	2	6.1	2	5.6	ns
^t PHL	LLAD	В	2	3.8	5.2	2	6.4	2	5.9	113
^t PLH	CLKBA	А	1.5	3.1	4.7	1.5	5.4	1.5	5.3	ns
^t PHL	CLNDA	A	1.5	3.1	4.3	1.5	5.2	1.5	5	113
^t PLH	CLKAB	В	1.5	3.3	4.7	1.5	6	1.5	5.5	ne
^t PHL	CLNAD	В	1.5	3.5	4.8	1.5	5.8	1.5	5.3	ns
^t PZH	OEBA	А	2	3.5	4.6	2	5.5	2	5.1	ne
^t PZL	OEBA	^	2	3.7	4.7	2	5.8	2	5.4	ns
^t PZH	OEAB	В	2	3.8	5.3	1.5	6.6	2	6.1	ns
^t PZL	OEAB		2	3.6	5.1	2	6.2	2	5.7	115
^t PHZ	OEBA	А	2	3.6	5.4	1.4	6.6	2	6.2	ne
t _{PLZ}	OEBA		1.5	3.2	4.7	1.5	5.8	1.5	5.4	ns
^t PHZ	OEAB	В	2	3.4	4.8	1.4	5.6	2	5.4	ns
^t PLZ	OLAB		1.5	3.2	4.5	1.5	5.7	1.5	5.2	119

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





25-Sep-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9859301QXA	ACTIVE	CFP	WD	56	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9859301QX A SNJ54ABT162601 WD	Samples
74ABT162601DGGRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT162601	Samples
74ABT162601DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT162601	Samples
74ABT162601DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT162601	Samples
SN74ABT162601DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT162601	Samples
SN74ABT162601DLG4	ACTIVE	SSOP	DL	56		TBD	Call TI	Call TI	-40 to 85	ABT162601	Samples
SN74ABT162601DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT162601	Samples
SNJ54ABT162601WD	ACTIVE	CFP	WD	56	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9859301QX A SNJ54ABT162601 WD	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.





25-Sep-2013

- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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OTHER QUALIFIED VERSIONS OF SN54ABT162601, SN74ABT162601:

Catalog: SN74ABT162601

Military: SN54ABT162601

NOTE: Qualified Version Definitions:

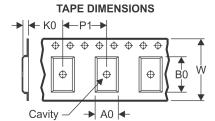
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

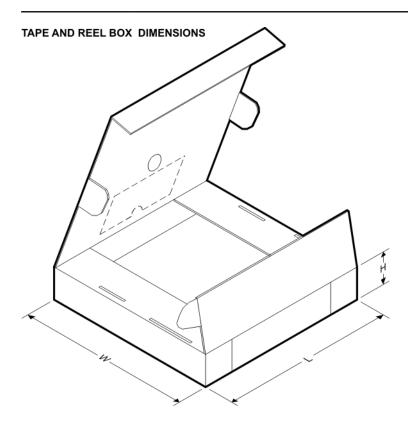


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT162601DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74ABT162601DLR	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1

PACKAGE MATERIALS INFORMATION

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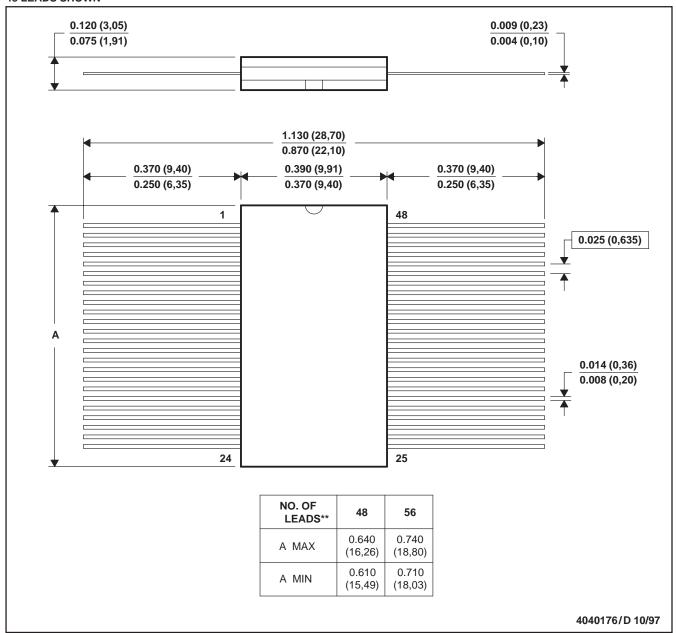
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN74ABT162601DGGR	TSSOP	DGG	56	2000	367.0	367.0	45.0	
SN74ABT162601DLR	SSOP	DL	56	1000	367.0	367.0	55.0	

WD (R-GDFP-F**)

CERAMIC DUAL FLATPACK

48 LEADS SHOWN



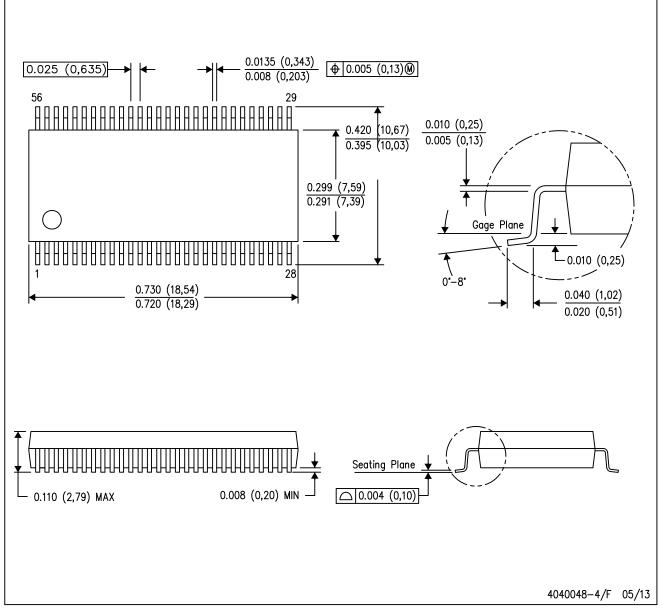
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only
- E. Falls within MIL STD 1835: GDFP1-F48 and JEDEC MO-146AA

GDFP1-F56 and JEDEC MO-146AB

DL (R-PDSO-G56)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

PowerPAD is a trademark of Texas Instruments.



DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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